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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/521,630	01/19/2005	Eiji Ueda	10873.1556USWO	4212	
53148 HAMRE SCH	HAMRE, SCHUMANN, MUELLER & LARSON P.C. P.O. BOX 2902-0902			EXAMINER	
P.O. BOX 290				NGUYEN, LINH THI	
MINNEAPOL	18, MN 55402		ART UNIT	PAPER NUMBER	
			2627		
	•				
•			MAIL DATE	DELIVERY MODE	
			11/27/2007	PAPER	

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

•	Application No.	Applicant(s)			
	10/521,630	UEDA ET AL.			
Office Action Summary	Examiner	Art Unit			
	Linh T. Nguyen	2627			
The MAILING DATE of this communication app Period for Reply	The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply				
A SHORTENED STATUTORY PERIOD FOR REPLY WHICHEVER IS LONGER, FROM THE MAILING DA  - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication.  - If NO period for reply is specified above, the maximum statutory period w  - Failure to reply within the set or extended period for reply will, by statute, Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATION 36(a). In no event, however, may a reply be tim vill apply and will expire SIX (6) MONTHS from cause the application to become ABANDONE	N. nely filed the mailing date of this communication. D (35 U.S.C. § 133).			
Status					
1)⊠ Responsive to communication(s) filed on <u>30 August 2007</u> .					
2a) This action is <b>FINAL</b> . 2b) ⊠ This	This action is <b>FINAL</b> . 2b)⊠ This action is non-final.				
3) Since this application is in condition for allowar	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is				
closed in accordance with the practice under Ex parte Quayle, 1935 C.D. 11, 453 O.G. 213.					
Disposition of Claims					
4) ⊠ Claim(s) 1-12 is/are pending in the application. 4a) Of the above claim(s) is/are withdray 5) □ Claim(s) is/are allowed. 6) ⊠ Claim(s) 1,2,5-8,11 and 12 is/are rejected. 7) ⊠ Claim(s) 3,4 9, and 10 is/are objected to. 8) □ Claim(s) are subject to restriction and/or	vn from consideration.				
Application Papers					
9) The specification is objected to by the Examiner.					
10) The drawing(s) filed on is/are: a) accepted or b) objected to by the Examiner.					
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).  Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).					
11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.					
Priority under 35 U.S.C. § 119		•			
<ul> <li>12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).</li> <li>a) All b) Some * c) None of: <ol> <li>Certified copies of the priority documents have been received.</li> <li>Certified copies of the priority documents have been received in Application No</li> <li>Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).</li> </ol> </li> <li>* See the attached detailed Office action for a list of the certified copies not received.</li> </ul>					
Attachment(s)					
1) Notice of References Cited (PTO-892)	4) Interview Summary				
Notice of Draftsperson's Patent Drawing Review (PTO-948)     Information Disclosure Statement(s) (PTO/SB/08)     Paper No(s)/Mail Date	Paper No(s)/Mail D 5)  Notice of Informal F 6)  Other:				

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#### **DETAILED ACTION**

## Continued Examination Under 37 CFR 1.114

A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after final rejection. Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's submission filed on 08/30/07 has been entered.

## Claim Objections

Claims 1 and 7 are objected to because of the following informalities: claim 1, used the term "variable value" is confusing because not sure if the applicant means a variable value that is constant or calculated value or power value. Appropriate correction is required.

## Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

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Claims 1, 2, 5-8, 11 and 12 are rejected under 35 U.S.C. 103(a) as being unpatentable over Kaneko et al (US Patent Number 5471449) in view of Ushiyama (US Patent number 6842412).

In regards to claims 1 and 7, Kaneko et al discloses a deficiency detecting apparatus (Fig. 1), which detects deficiencies on an information medium that are unable to be recorded or reproduced when an information signal is recorded/reproduced with respect to the information medium using a light beam generated by a laser light source (Column 2 lines 14-20), comprising: a power adjusting section (APC) for adjusting an emitting power of the laser light source to an optimum value (Column 3, lines 56-60); and a deficiency detecting section for comparing a threshold value (Fig. 1, element 55).

In the same field of endeavor, Ushiyama et al discloses a threshold hold value determined by calculating a variable value of the emitting power of the laser light source (Figs. 5-6) adjusted by the power adjusting section (Fig. 1, elements 16 and 18) with a value corresponding to reflected light that is the light beam reflected by an information layer of the information medium (Column 7, lines 29-34). At the time of the invention it would have been obvious to a person of ordinary skill in the art to combine the defect detection by comparing a threshold value of Kaneko et al by using the threshold value that is determine by the emitting power as suggested by Ushiyama. The motivation for doing so would have been to optimized recording power and minimizes defocusing of laser spot (Column 8, lines 18-29).

In regards to claims 2 and 8, Kaneko et al discloses deficiency detection by comparing a threshold value. However, Kaneko does not but Ushiyama et al discloses

a deficiency detecting apparatus, wherein the threshold value is determine in accordance with an emitting power selected from a predetermined range of laser power (Fig. 4). The motivation is the same as claim 1 above.

In regards to claims 5 and 11, Kaneko et al discloses deficiency detection by comparing a threshold value. However, Kaneko et al does not but Ushiyama et al discloses, an emitting power adjusted by the power adjusting section is composed of plural power levels (Fig. 4), and the deficiency detecting section determines the threshold value in accordance with the highest power level among the plural power levels (Fig. 5, the highest power is writing power). The motivation is the same as claim 1 above.

In regards to claims 6 and 12, Kaneko et al does not but Ushiyama et al discloses an apparatus, wherein the emitting power adjusted by the power adjusting section is composed of plural power levels (Fig. 4), wherein the deficiency detecting section determines the threshold value in accordance with an erasing power level that is used for erasing among the plural power levels (Fig. 6).

# Allowable Subject Matter

Claims 3, 4, 9 and 10 are objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.

In regards to claims 3 and 9, none of the reference alone or in combination discloses a threshold value determine by an average of emitting power.

In regards to claims 4 and 10, none of the reference alone or in combination discloses a threshold value determine by the sum of emitting power.

### Conclusion .

The prior art made of record and not relied upon is considered pertinent to applicant's disclosure. Ogawa and Hodkinson et al are cited to show other closely related arts on calculating adjust emitting power to determine a deficiency.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Linh T. Nguyen whose telephone number is 571-272-5513. The examiner can normally be reached on 8:30am-5:00pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Wayne Young can be reached on 571-272-4483. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

LN November 21, 2007 /Wayne Young/ SPE AU 2627